Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/664,436	FUJII ET AL.	
Examiner	Art Unit	

Paul S. Hyun

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
performed inventor name search	3/20/2006	PSH	
searched references cited in IDS			
text search	3/20/06-		
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